

**Laboratory** Hi-Tech Calibration Laboratory, 325, 3<sup>rd</sup> Floor, Radha Palace,  
Gurudwara Road, Gurgaon, Haryana

**Accreditation Standard** ISO/IEC 17025:2005

**Discipline** Mechanical Calibration **Issue Date** 02.09.2014

**Certificate Number** C-0829 **Valid Until** 01.09.2016

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Quantity Measured/ Instrument	Range / Frequency	*Calibration Measurement Capability ( $\pm$ )	Remarks
<b>I. PRESSURE</b>			
1. Hydraulic Pressure : Digital/Dial Pressure gauges*	0 to 400 kg/cm <sup>2</sup>	2.0 kg/ cm <sup>2</sup>	Using Digital Pressure Gauge by Comparison Method
<b>II. DIMENSION</b>			
1. Height Gauge \$ (Vernier/Dial/Digital) L.C: 0.01 mm <sup>Φ</sup>	0 to 300 mm 0 to 600 mm	17.7 $\mu$ m 21.5 $\mu$ m	Using Caliper Checker
2. Caliper \$ (Vernier/Dial/Digital) L.C: 0.01 mm <sup>Φ</sup>	0 to 300 mm 0 to 600 mm	14.7 $\mu$ m 21.5 $\mu$ m	Using Caliper Checker
3. External Micrometer \$ L.C: 0.001 mm L.C: 0.01 mm	0 to 100 mm 0 to 150 mm	1.9 $\mu$ m 7.0 $\mu$ m	Using Slip Gauge Blocks
4. Plain Plug Gauge \$ /Measuring Pin/ Thread Measuring Wire/ 3 Wire Unit	Upto 25 mm >25mm to 100mm	2.3 $\mu$ m 4 $\mu$ m	Using External Micrometer Using Slip Gauge & Digital Indicator
5. Electronic Probe \$	0 to 25 mm	1.1 $\mu$ m	Using Slip Gauge Blocks
6. Feeler Gauge/ \$ Standard Foil	Upto 1 mm	2.4 $\mu$ m	Using Digital Micrometer

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7. Dial Bore Gauges \$ L.C: 0.01 mm (Travel Only)	Transmission Accuracy Upto 2 mm	6.0 $\mu$ m 1.5 $\mu$ m	Using Dial Calibration Tester
8. Dial Thickness Gauge \$ L.C : 0.01 mm	0 to 100 mm	7.6 $\mu$ m	Using Slip Gauge Blocks
9. Lever Dial \$ L.C : 0.01/0.002 mm L.C : 0.001mm	0 to 1.4 mm 0 to 0.14 mm	3.0 $\mu$ m 1.5 $\mu$ m	Using Dial Calibration Tester
10. Plunger Dial \$ (Dial Gauge Indicator) L.C : 0.001mm <sup>Φ</sup>	0 to 25 mm	1.8 $\mu$ m	Using Dial Calibration Tester
11. Snap Gauge \$	0 to 100 mm	3.0 $\mu$ m	Using Slip Gauge Blocks
12. Bevel Protector /\$ Combination Set / Angle Protector L.C : 5' <sup>Φ</sup>	0°-180°-0°	3.7'	Using Angle Gauge Blocks
13. Thread Plug Gauge \$	Upto 50 mm	3.7 $\mu$ m	Using 3 Wire Pin & Digital Micrometer
14. V-Block\$ Flatness Parallelism Symmetry	Upto 150 mm	4.0 $\mu$ m 6.0 $\mu$ m 6.0 $\mu$ m	Using Slip Gauge, Digital Indicator & Mandrel

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Quantity Measured/ Instrument	Range / Frequency	*Calibration Measurement Capability ( $\pm$ )	Remarks
15. Surface Plate <sup>\$</sup>	1000 mm x 1000 mm	$1.6 \sqrt{(L+W)} / 125 \mu\text{m}$ L&W in mm	Using Electronic Level
16. Ford Cup <sup>\$</sup> Orifice Diameter	Upto 10 mm	14 $\mu\text{m}$	Using Digital Caliper
17. Coating Thickness Gauge <sup>\$</sup> (Digital & Dial Type)	Upto 100 $\mu\text{m}$ >100 $\mu\text{m}$ to 817 $\mu\text{m}$	2.4 $\mu\text{m}$ 3.0 $\mu\text{m}$	Using Standard Foils Set
18. Profile Projector <sup>*</sup> X/Y Axis Movement Angle Magnification	0 to 300 mm 0 to 360° 10 X to 100 X	5 $\mu\text{m}$ 3' 0.3 %	Using Slip Gauge Blocks, Angle Gauge & Digital Caliper
19. Surface Plate <sup>*</sup>	4000 mm x 4000 mm (L & W )	$1.6 \sqrt{(L+W)} / 125 \mu\text{m}$ L & W in mm	Using Electronic Level

\* Measurement Capability is expressed as an uncertainty ( $\pm$ ) at a confidence probability of 95%

<sup>\$</sup>Only in Permanent Laboratory

<sup>\*</sup>Only for Site Calibration

<sup>Φ</sup> Laboratory can also calibrate instruments/devices of coarser resolution / least count within the accredited range using same reference standard/ master equipment under the scope of accreditation.